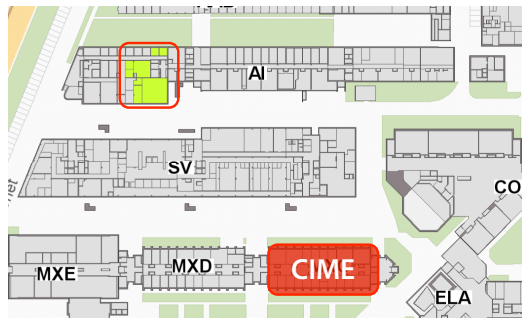
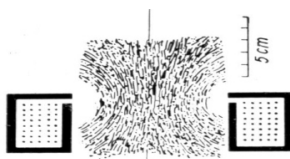


1. Electron lenses
2. Layout of the electron microscope
3. Generation of a TEM image
4. Generation of an SEM image



Magnetic fields could be used as lenses



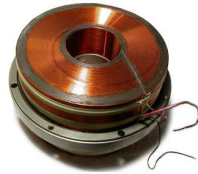
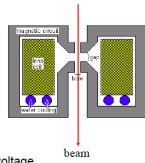
Electron optics was born in 1927, when Hans Busch showed that the elementary lens equation is applicable to short magnetic coils.

Magnetic fields could be used as lenses

- the focal length is given by:

$$f = \frac{K \cdot U}{(N \cdot I)^2}$$

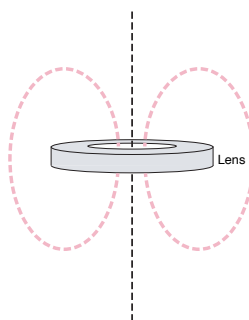
K : constant
U : accelerating voltage
N : windings
I : lens current



Principles of Transmission Electron Microscopy

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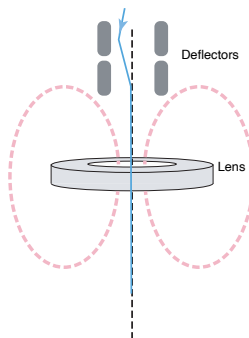
Components of an electron lens



Principles of Transmission Electron Microscopy

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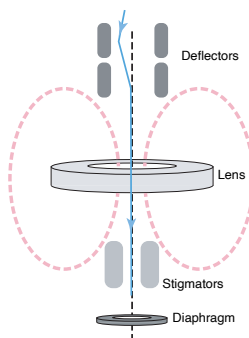
Components of an electron lens



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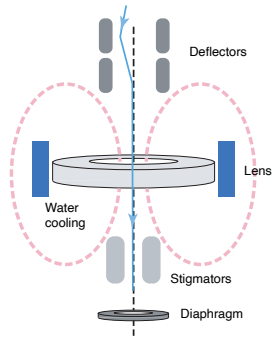
Components of an electron lens



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Components of an electron lens



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Ernst Ruska & Max Knoll 1932

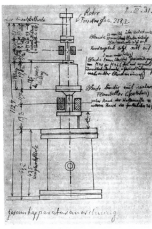
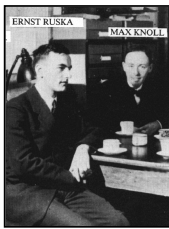


Fig. 18. Schéma du premier microscope électronique par Max Knoll et Ernst Ruska (1932).

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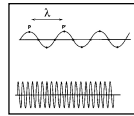
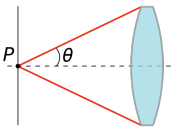
Principles of Transmission Electron Microscopy

The resolving power of a microscope is proportional to λ/NA

λ = wavelength

NA = numerical aperture

$NA = n \sin \theta$ (n = index of refraction)



$$\lambda = \frac{h}{p}$$

$$v = \sqrt{\frac{2eU}{M_0}}$$

h = Planck's constant (6.624×10^{-27} erg/second)

m = mass of an electron (9.11×10^{-28} gram = $1/1837$ of a proton)

v = velocity of the electron

In electron microscopy the refractive index cannot exceed 1.0, the half angle is very small, and thus the only thing that can be adjusted is decreasing the wavelength of illumination

Beam of 100 KeV has a wavelength of 0.0389 - theoretical resolution of 0.0195 Angstroms

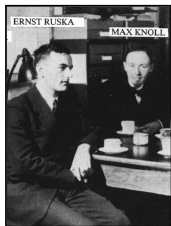
In reality most TEMs will only have an actual resolution of around 2.4 Angstroms at 100KeV

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The First Electron Microscope

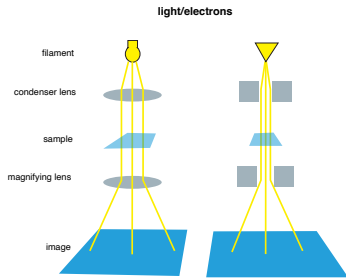
Ernst Ruska & Max Knoll 1932



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Principles of Transmission Electron Microscopy

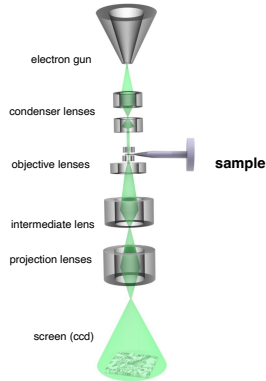
Light microscopy and TEM Analogy



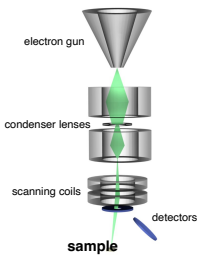
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Principles of Transmission Electron Microscopy

Transmission electron microscope



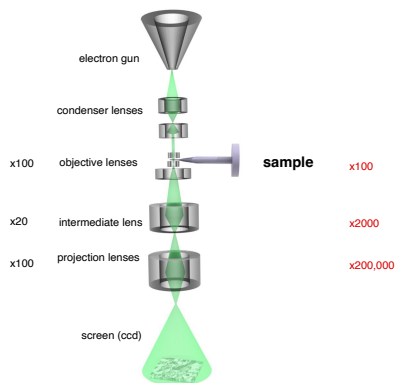
Scanning electron microscope



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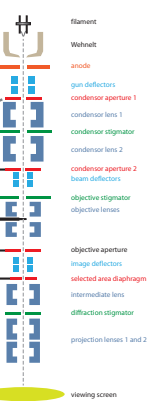
Principles of Transmission Electron Microscopy

Transmission electron microscope



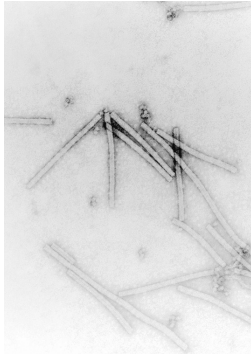
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Helmut Ruska, 1939, imaged the tobacco virus

Technique - negative staining

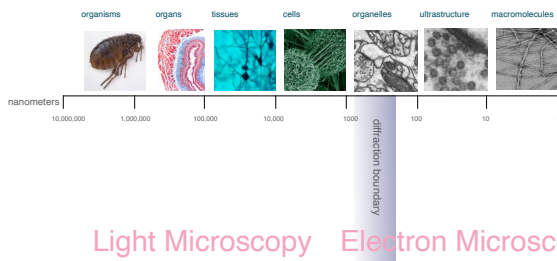
- virus dried to a thin film
- solution of electron dense stain applied
- dried
- imaged

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Scale of biological structures

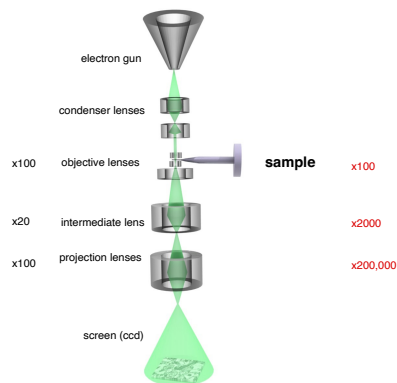
Why we need electron microscopes to see biological structures



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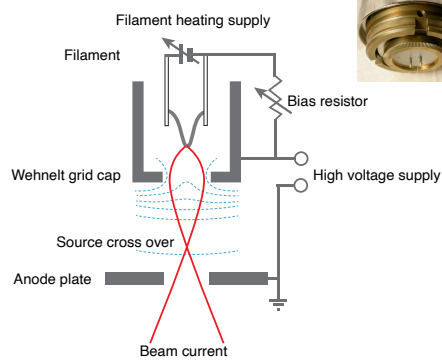
Transmission electron microscope



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Principles of Transmission Electron Microscopy

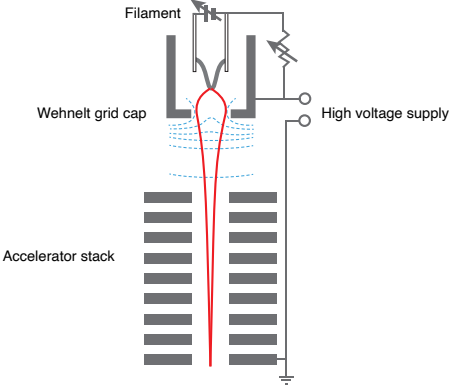
Electron Gun



EPFL

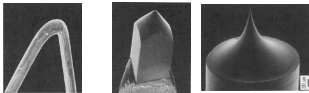
Principles of Transmission Electron Microscopy

Electron Gun



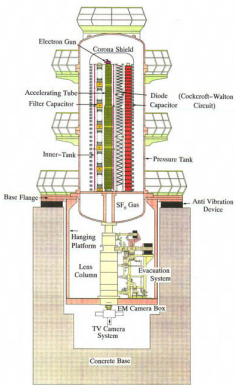
Electrons need to be emitted from the same place and with the same speed (coherence)

- Spatial coherence - all electrons need to come from the same place
- Temporal coherence - all electrons need to have the same speed (same wave length)

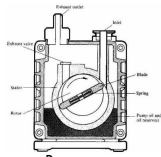


Emission	Thermionic		Field emission
	tungsten	LaB6	FE
Current density (A/cm ²)	2	100	10'000
Energy spread (eV)	1-5	0.5-3.0	0.2-0.3
Operating lifetime	>50	>500	>1000
Vacuum (torr)	10 ⁻⁴ -10 ⁻⁵	10 ⁻⁴ -10 ⁻⁷	10 ⁻⁹ -10 ⁻¹⁰
Operating temperature (K)	2700	2000	300
Effective crossover size (nm)	50	10	0.01

3 million volt microscope, Osaka, Japan



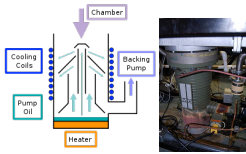
Vacuum Pumping Systems



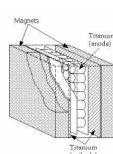
Rotary pump
 $10^{-1} - 10^{-2}$ mbar



Turbomolecular pump
 $10^{-5} - 10^{-7}$ mbar



Oil diffusion pump
 $10^{-5} - 10^{-7}$ mbar

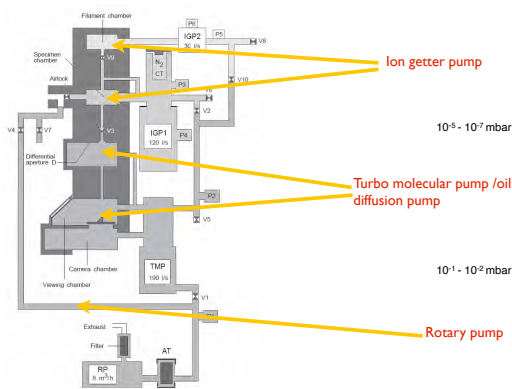


ion getter pump
 $10^{-7} - 10^{-10}$ mbar

Principles of Transmission Electron Microscopy

EPFL

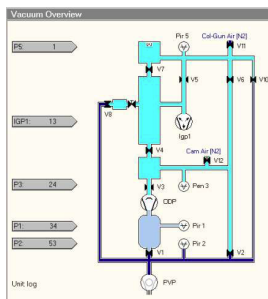
Electrons can only travel distances in a vacuum



Atmosphere: 1000 mbar

Principles of Transmission Electron Microscopy

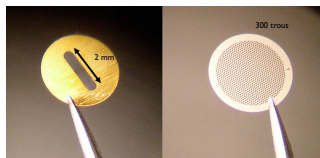
EPFL



Principles of Transmission Electron Microscopy

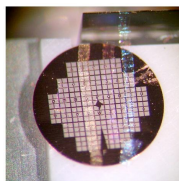
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Typical EM grids for holding sections



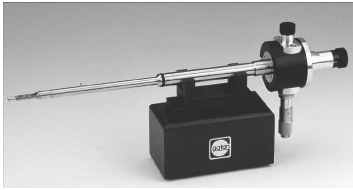
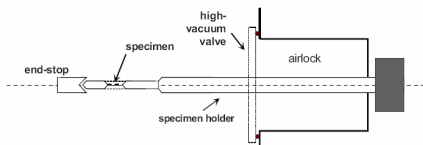
single slot grid

multi hole grid



cryo sections placed on grid

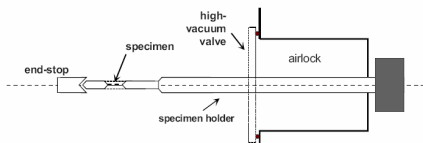
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Specimen size:
 •3 mm in diameter!
 •Ca. 100 nm in thickness
 •electron transparent

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Principles of Transmission Electron Microscopy

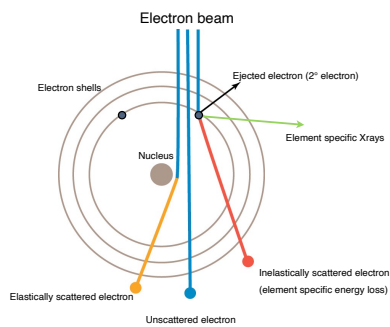


Specimen size:
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 •Ca. 100 nm in thickness
 •electron transparent

EPFL

Principles of Transmission Electron Microscopy

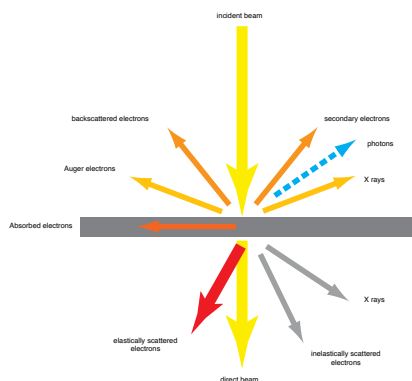
High energy electrons transmitting through a sample



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Principles of Transmission Electron Microscopy

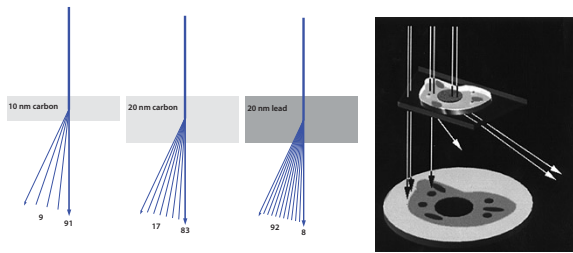
TEM / SEM interaction of electrons with the sample



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Principles of Transmission Electron Microscopy

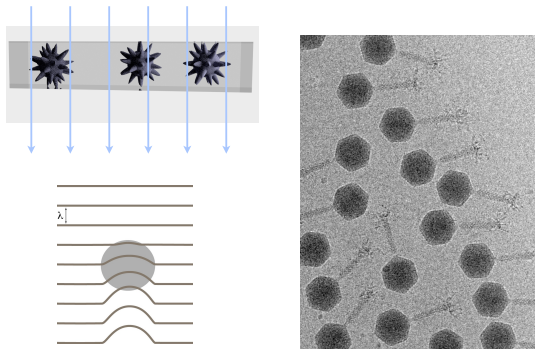
Electrons passing through the sample are deviated depending on the composition of the sample - **amplitude contrast imaging**



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Principles of Transmission Electron Microscopy

Phase contrast imaging - frozen hydrated sample



- Good preservation
- High resolution
- Time resolution

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Principles of Transmission Electron Microscopy

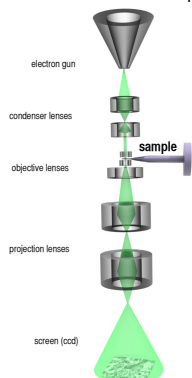
Image capture devices

- Fluorescent screen
- TV camera
- Photographic film
- CCD camera
- Direct electron detector

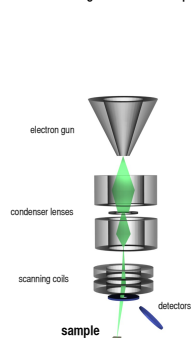
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Principles of Transmission Electron Microscopy

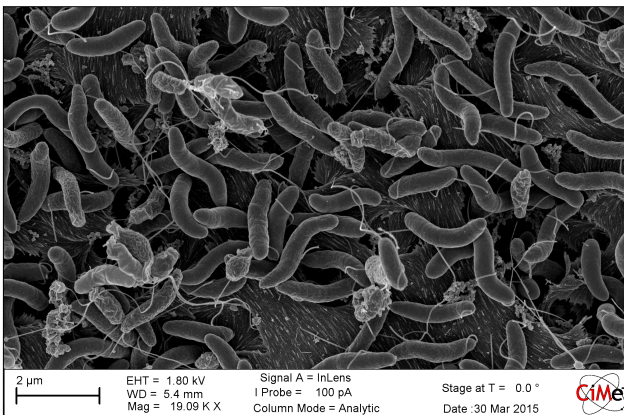
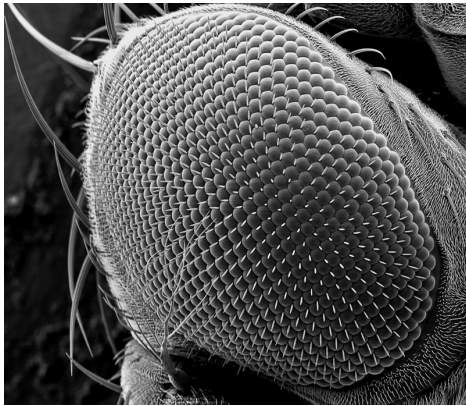
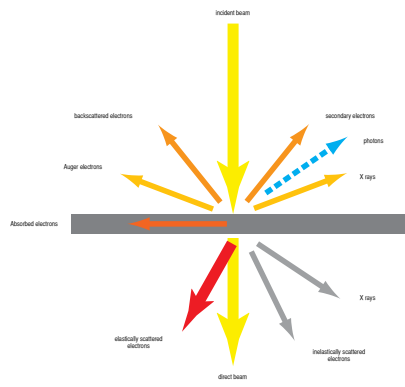
Transmission electron microscope



Scanning electron microscope



TEM / SEM interaction of electrons with the sample



2 μm EHT = 1.80 kV Signal A = InLens
WD = 5.4 mm I Probe = 100 pA
Mag = 19.09 K X Column Mode = Analytic Stage at T = 0.0 °
Date :30 Mar 2015 CIME